

FEB 04 2008

PTO/SB/08A (07-06)

Approved for use through 03/31/2007. OMB 0651-0031

U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449 (Rev. 03-01-03)

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

(Use as many sheets as necessary)

Sheet 1 of 2

**Complete if Known**

Application Number	10/739,084
Filing Date	December 19, 2003
First Named Inventor	Shunpei YAMAZAKI et al.
Art Unit	2871
Examiner Name	J. DUDEK
Attorney Docket Number	0756-7232

**U. S. PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US-5436744	07-25-1995	ARLEDGE, J et al.	
		US-5834071	11-10-1998	LIN, K	
		US-5567967	10-22-1996	KUSUMOTO, N	
		US-6961111	11-01-2005	KURAMASU, K	
		US-6191838	02-20-2001	MURAMATSU, E	
		US-2005/0139918	06-30-2005	LEE, S	
		US-2002/0159010*	10-31-2002	MAEDA, A et al.	
		US-2003/0090450	05-15-2003	INADA, K et al.	
		US-2001/0000763	05-03-2001	MURAMATSU, E	
		US-2006/0097286	05-11-2006	CHUNG, Y et al.	
		US-2001/0009342	07-26-2001	FURUKAWA, O et al.	
		US-2003/0012870	01-16-2003	SAKURADA, K	
		US-2003/0067576	04-10-2003	CHO, H	
		US-2003/0089132	05-15-2003	KUSUDA, T	
		US-2004/0108987	06-10-2004	PARK, J et al.	
		US-2005/0106841	05-19-2005	I-CHANG, T	
		US-6391747	05-21-2002	OKUMURA, H et al.	
		US-7239564	07-03-2007	MUTAGUCHI, K	
		US-6456353	09-24-2002	CHEN, Y	

**FOREIGN PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> - Number <sup>4</sup> - Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>

Examiner Signature	/James Dudek/	Date Considered	04/09/2008
--------------------	---------------	-----------------	------------

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. 1 Applicant's unique citation designation number (optional). 2 See Kind Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. 3 Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5 Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST 16 if possible. 6 Applicant is to place a check mark here if English language Translation is attached.

This collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

If you need assistance in completing the form, call 1-800-PTO-9199 (1-800-786-9199) and select option 2.

ALL REFERENCES CONSIDERED WHERE LINED THROUGH. //JD/

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /JD/